

ECAL2 Preliminary Data Analysis Towards Online Feature Extraction

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Overview

DPP Strategy for high resolution amplitude measurements

Ideal pulse model

- Pulses selection criteria

- Single pulse model

- Pulse plus reflection model

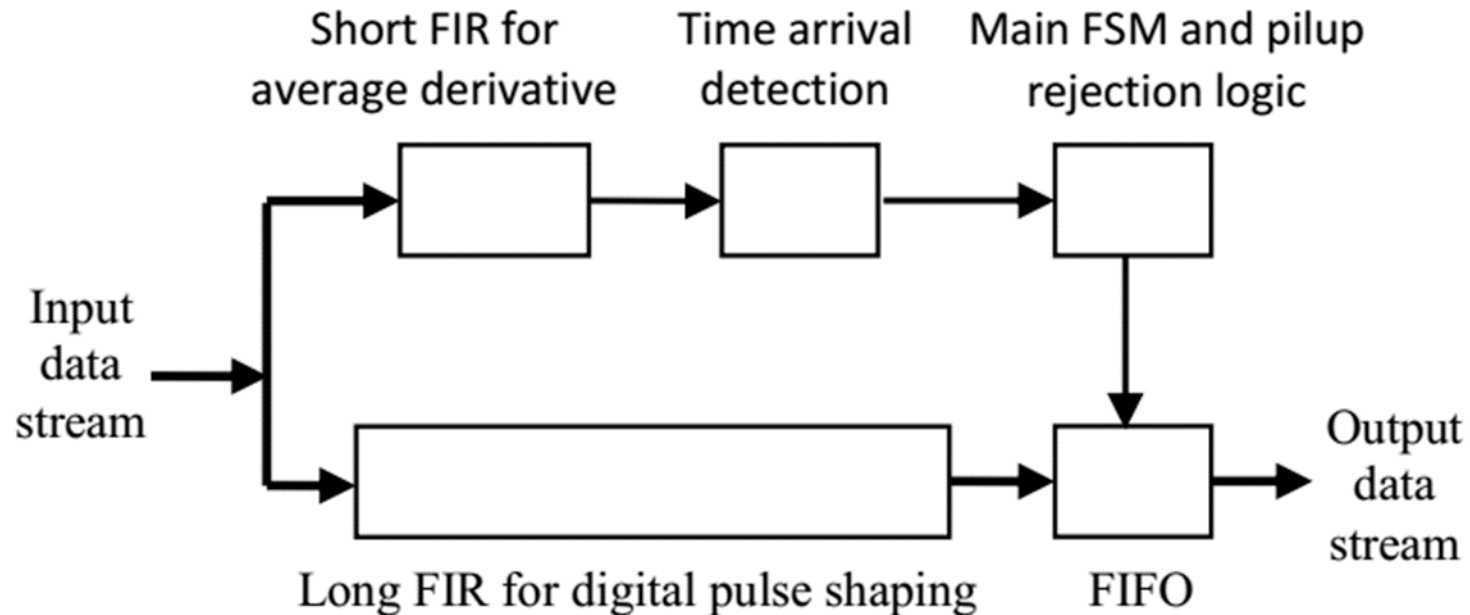
Noise analysis

- Burst regime qualitative description

- FFT

- Autocorrelation

Digital Pulse Processing Strategy for High Resolution Amplitude Measurement

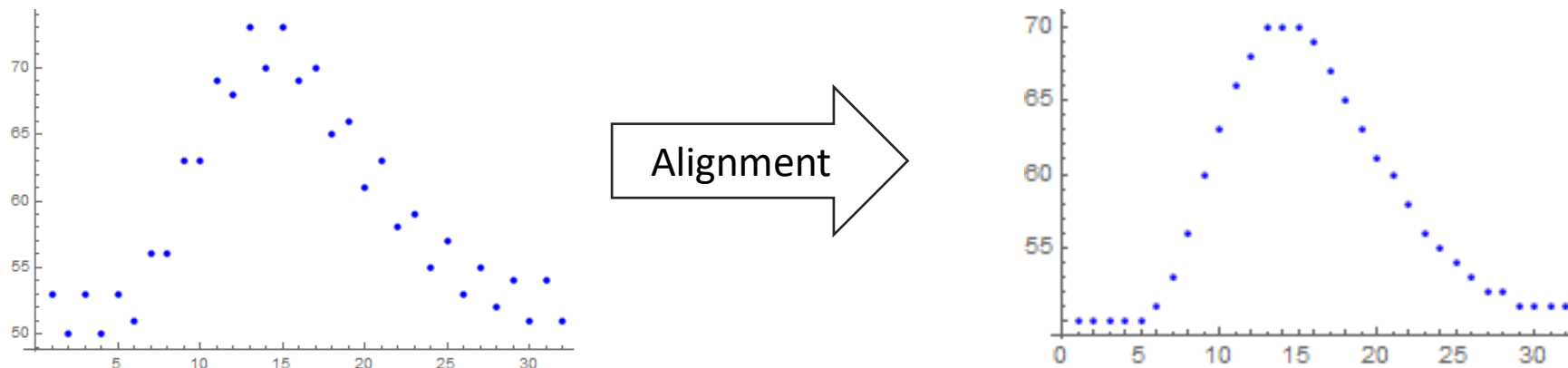


Data alignment

- Analyzed data has been obtained using 2 ADCs interleaved
- Each ADC has different offset

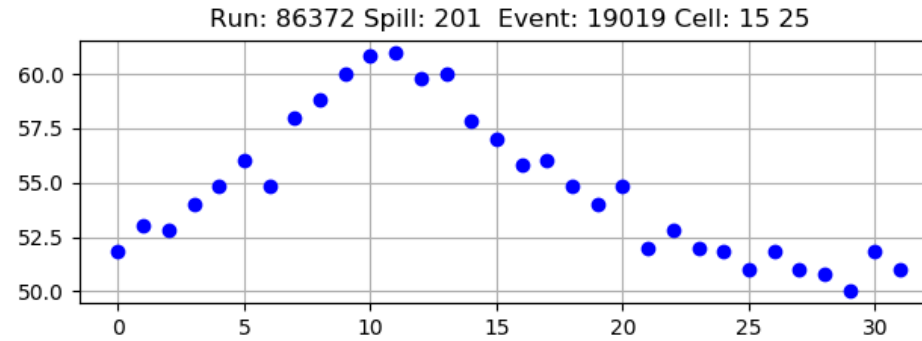
$$\overline{x_{odd}} - \overline{x_{even}} = d$$

d is subtracted from x_{even} and a new signal is created with its values aligned

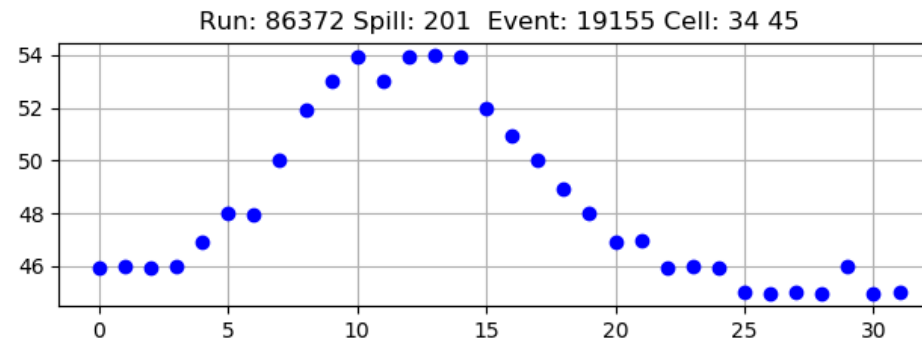


Some Typical Pulses

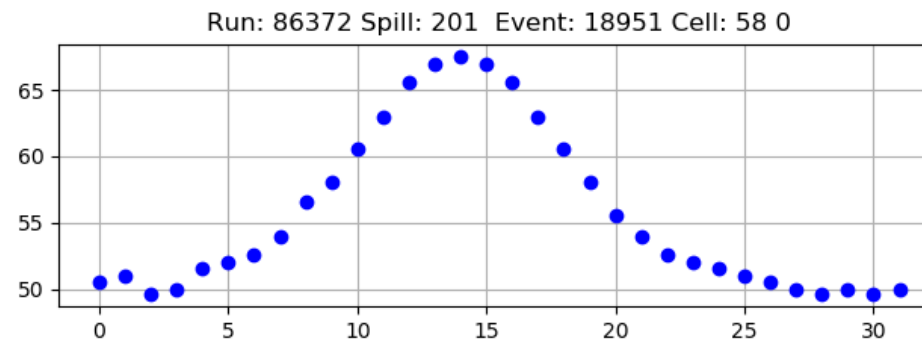
- Triangular



- Truncated



- Beautiful



Best Pulses Selection Criteria

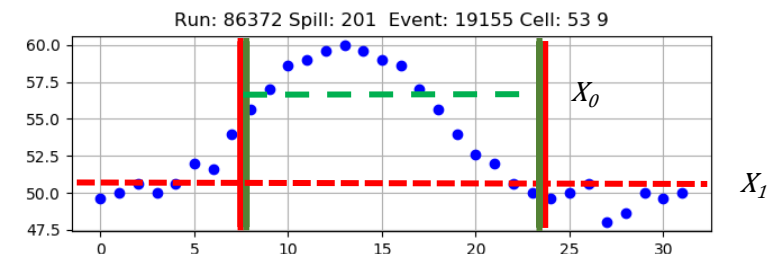
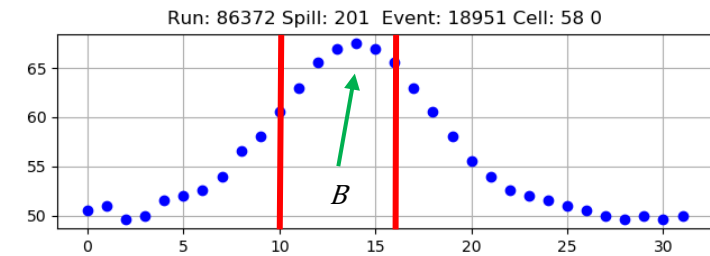
- Barycenter criteria:

Value must be between lower and higher limits

$$\text{with Barycenter } B = \frac{\sum i_j A_j}{\sum A_j} ; l_{inf} < B < l_{sup}$$

- Mean difference criteria

This is used to reject negative pulses



$$\overline{X_0[8:24]} - \overline{X_1[0:8,24:32]} > \text{threshold}$$

Fitting Model : CR-RC^N Shaper Single Pulse

$$\bullet F(t, t_0, \tau, off, a, N) = \begin{cases} off & , t_0 < t \\ off + a \frac{e^N \left(\frac{(t-t_0)}{\tau}\right)^N e^{-\frac{(t-t_0)}{\tau}}}{N^N} & , t \geq t_0 \end{cases}$$

off := offset

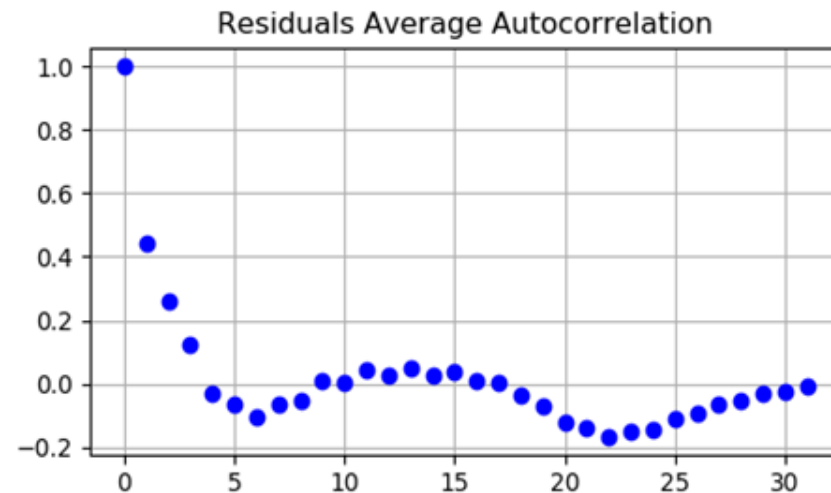
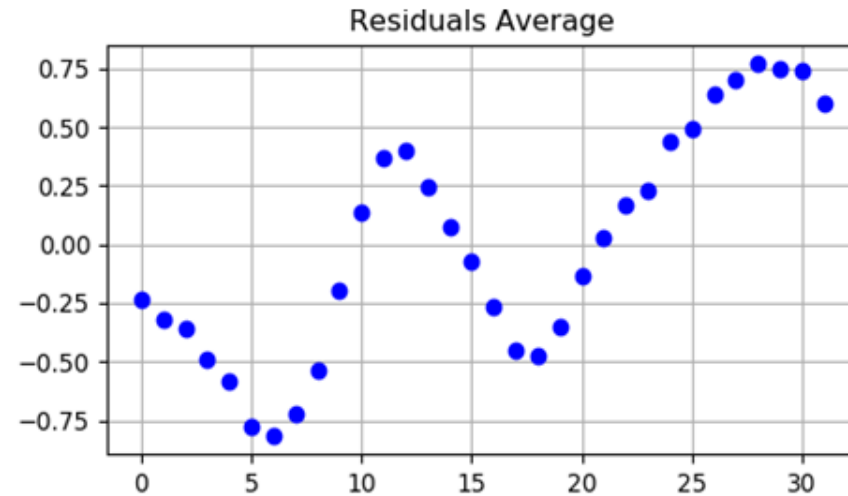
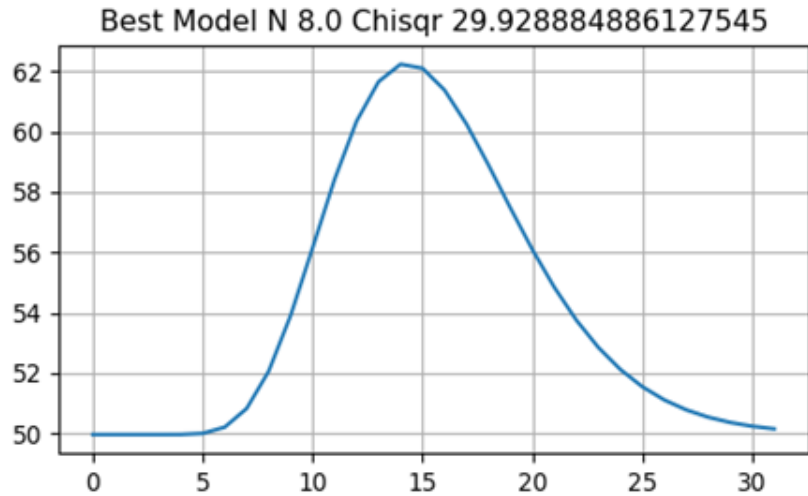
t_0 := time of arrival

a := amplitude

τ := exponential time

F := CR-RC^N shaper

Fitting Results



Fitting Model: Main Pulse Plus Reflection

$$F(t, t_0, \tau, off, a, N, k, dt) =$$

$$\begin{cases} off & , t_0 < t \\ off + a \frac{e^N \left(\frac{(t - t_0)}{\tau}\right)^N e^{-\frac{(t-t_0)}{\tau}}}{N^N} & , t_0 + dt > t \geq t_0 \\ off + a \frac{e^N \left(\frac{(t - t_0)}{\tau}\right)^N e^{-\frac{(t-t_0)}{\tau}}}{N^N} + k * a \frac{e^N \left(\frac{(t - (t_0+dt))}{\tau}\right)^N e^{-\frac{(t-(t_0+dt))}{\tau}}}{N^N} & , t \geq t_0 + dt \end{cases}$$

off := offset

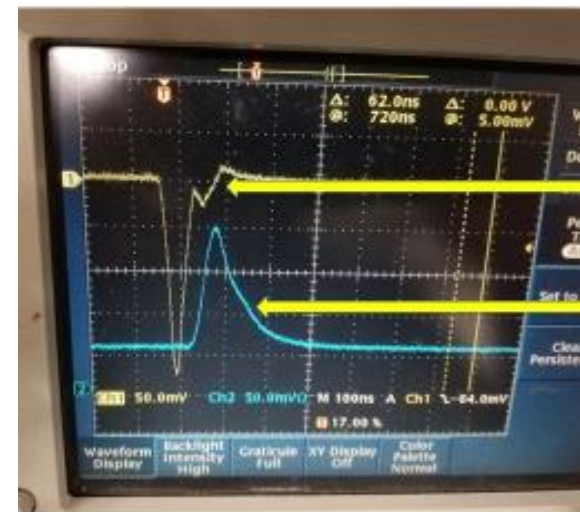
t_0 := time of arrival

a := amplitude

τ := exponential time

k := reflection amplitude factor

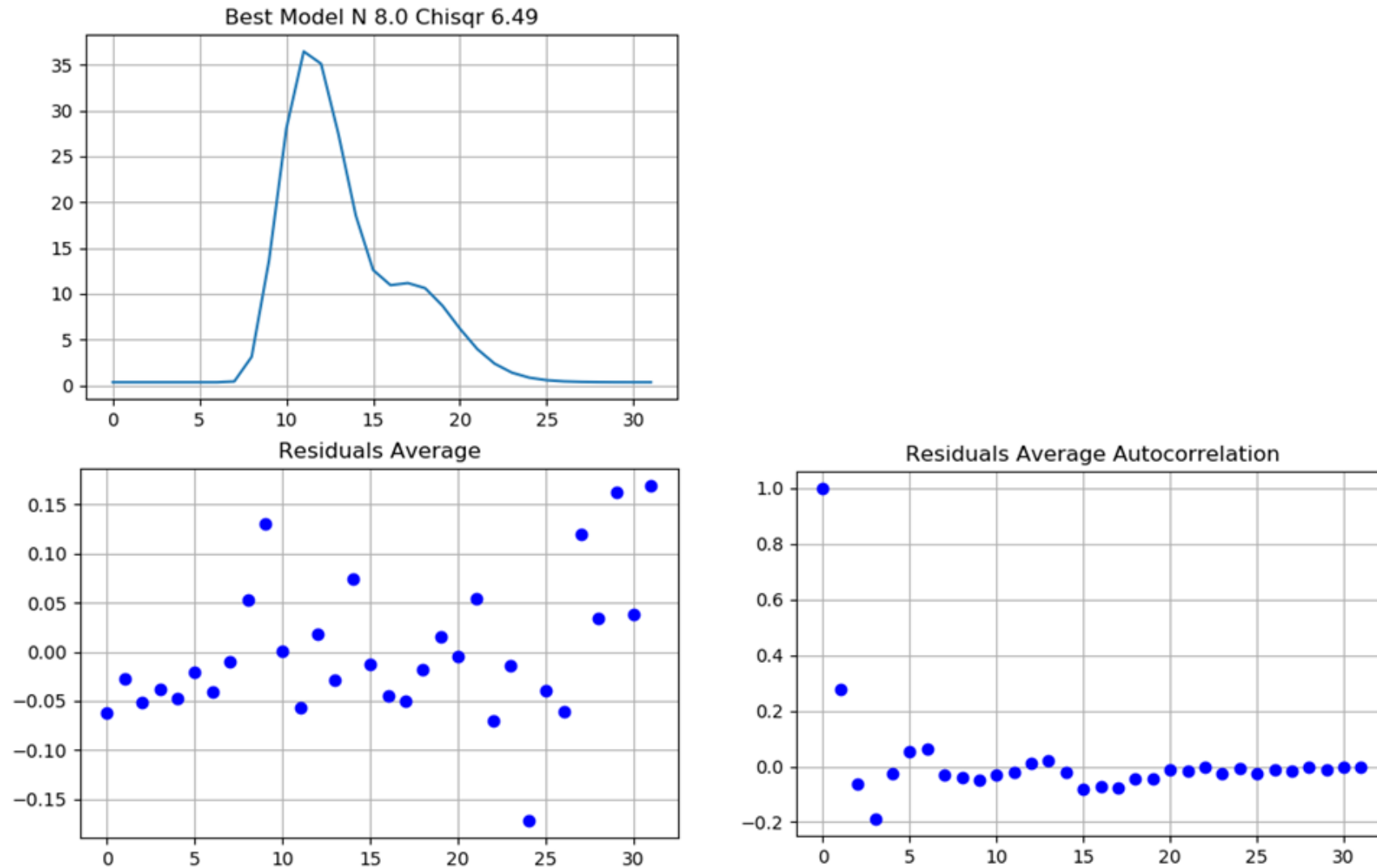
dt := time delay

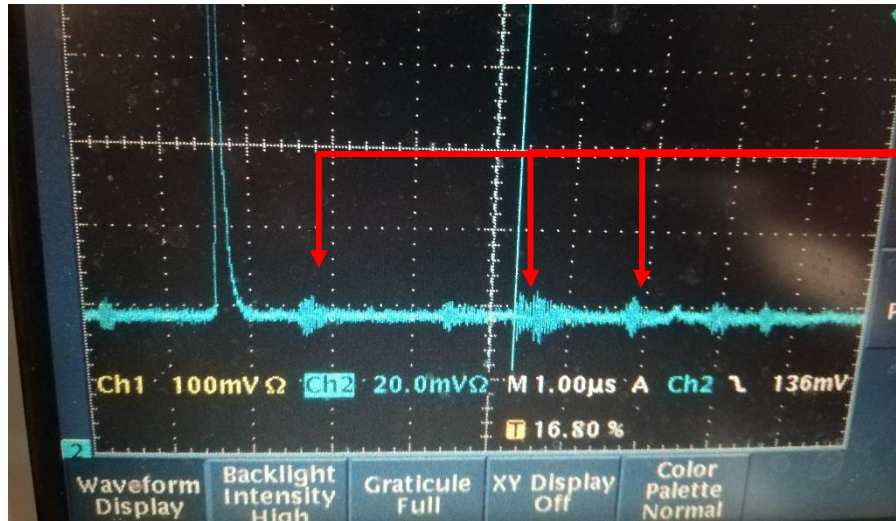


Reflection of
PMT pulse

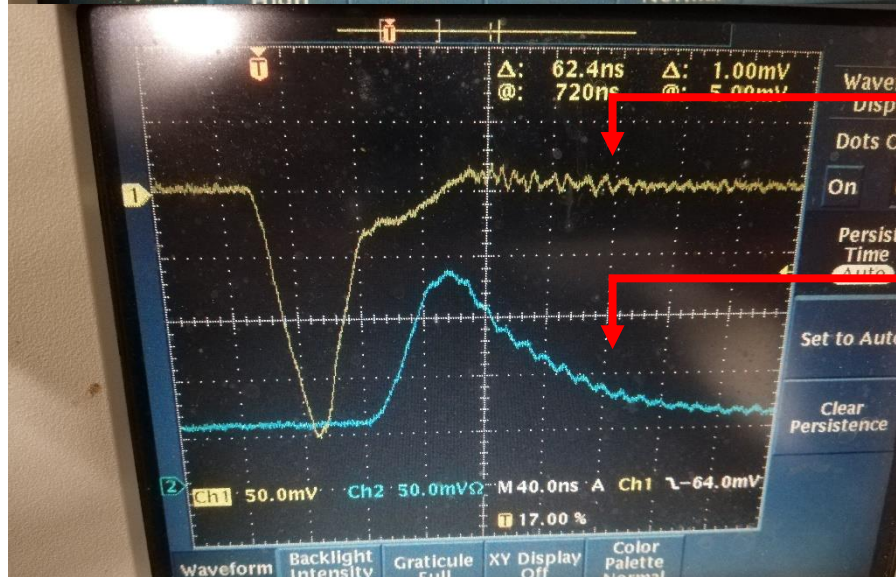
Matching reflection
on Shaper output

Fitting results





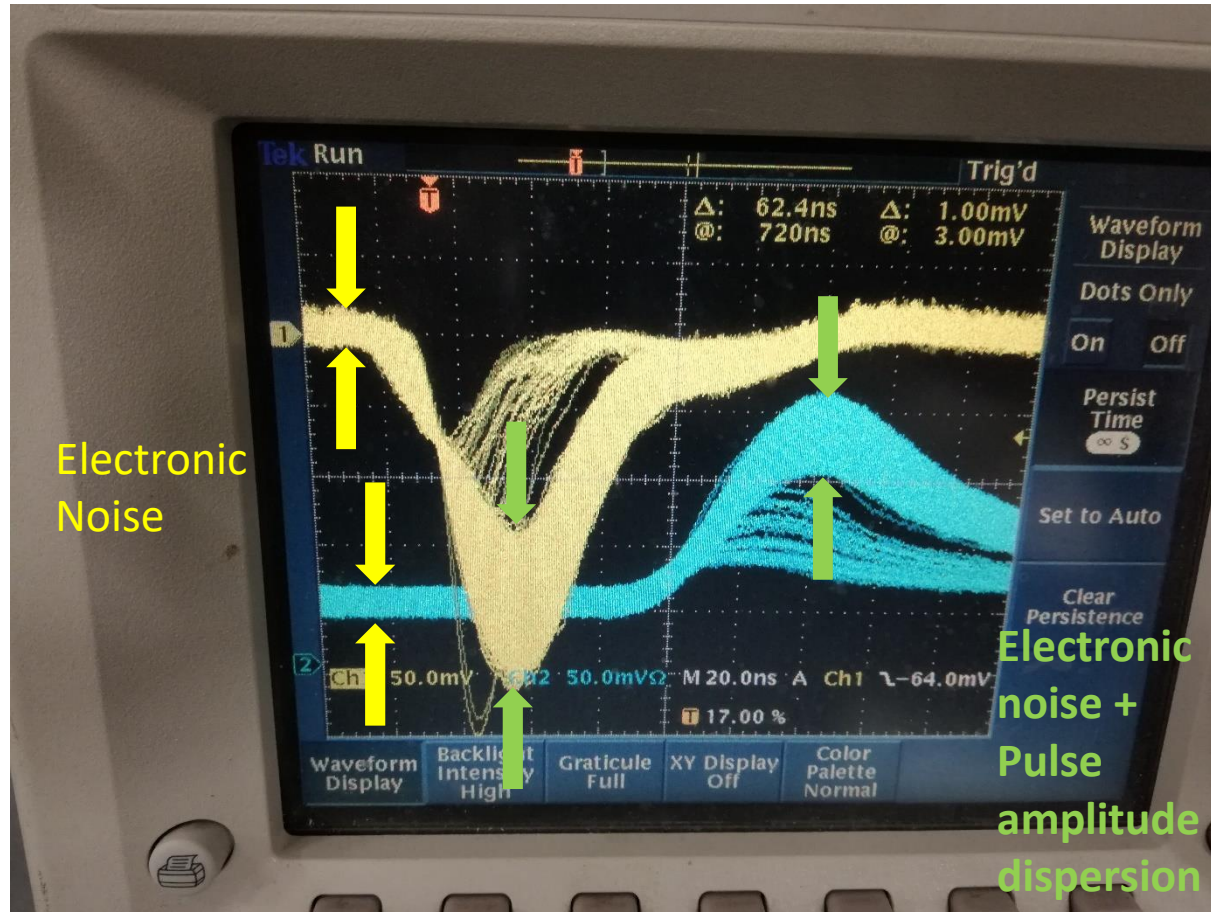
Bursts of noise zoomed out



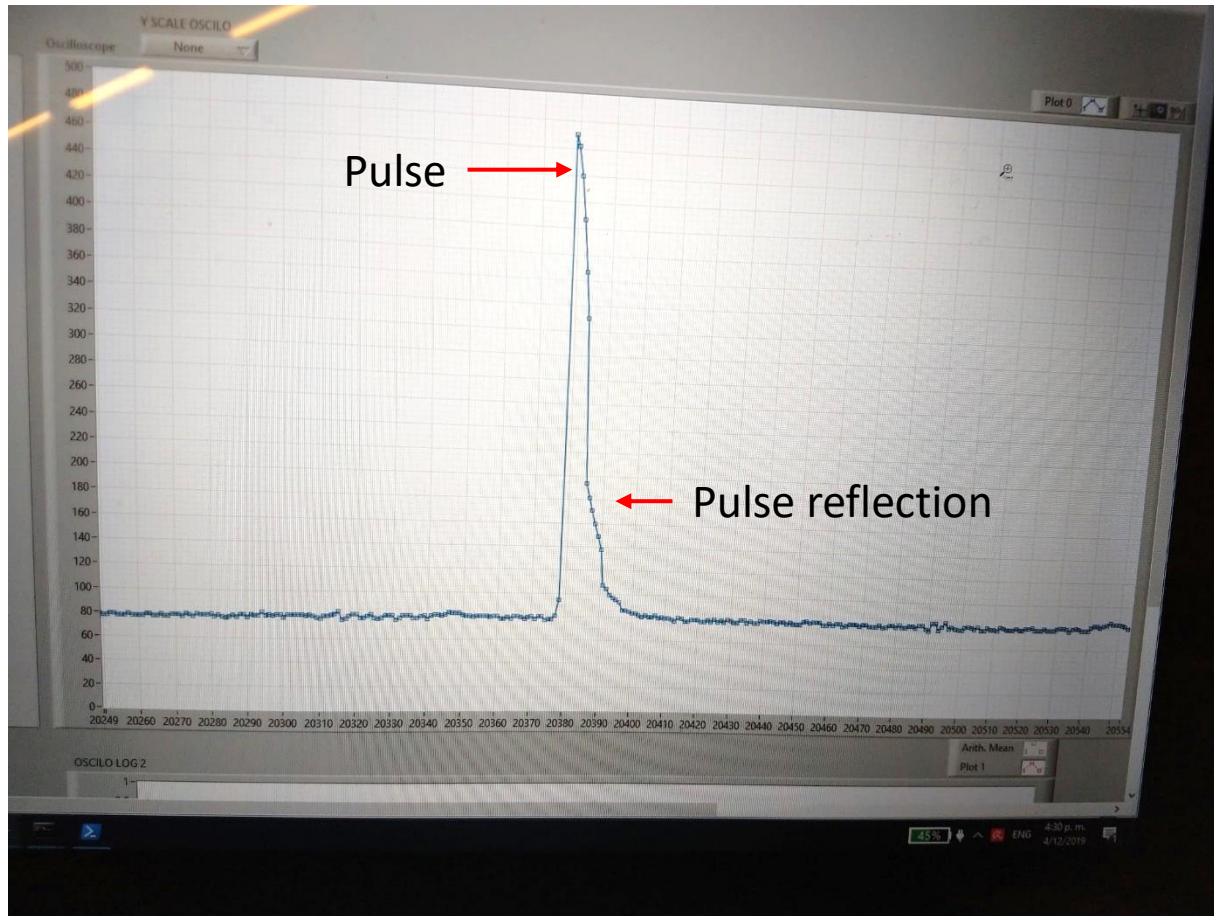
Burst of noise before shaper

Burst of noise after shaper

Analog Persistence



SoC-FPGA Oscilloscope

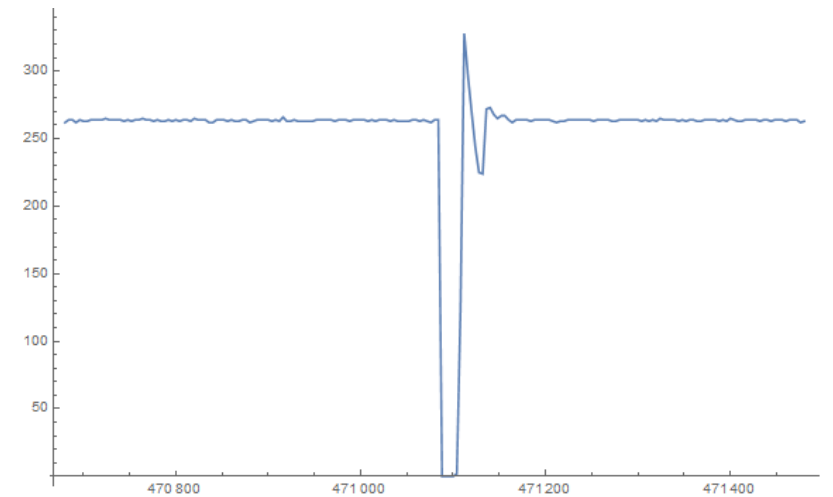
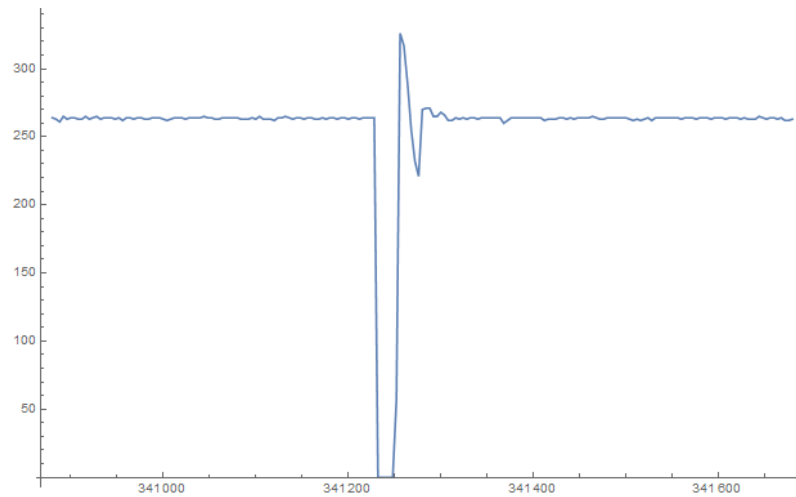
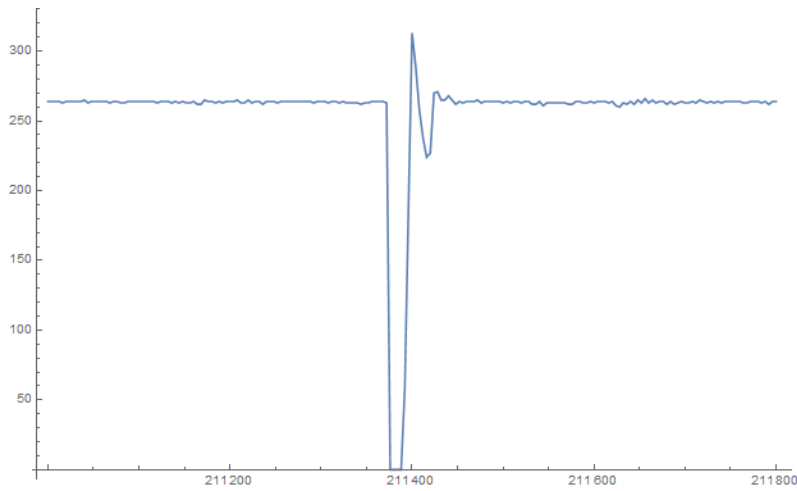


LabView GUI Plot of acquired data from CIAA+ADC500.

Data is plotted in real time on a PC via Ethernet.

Pulses before Shaper

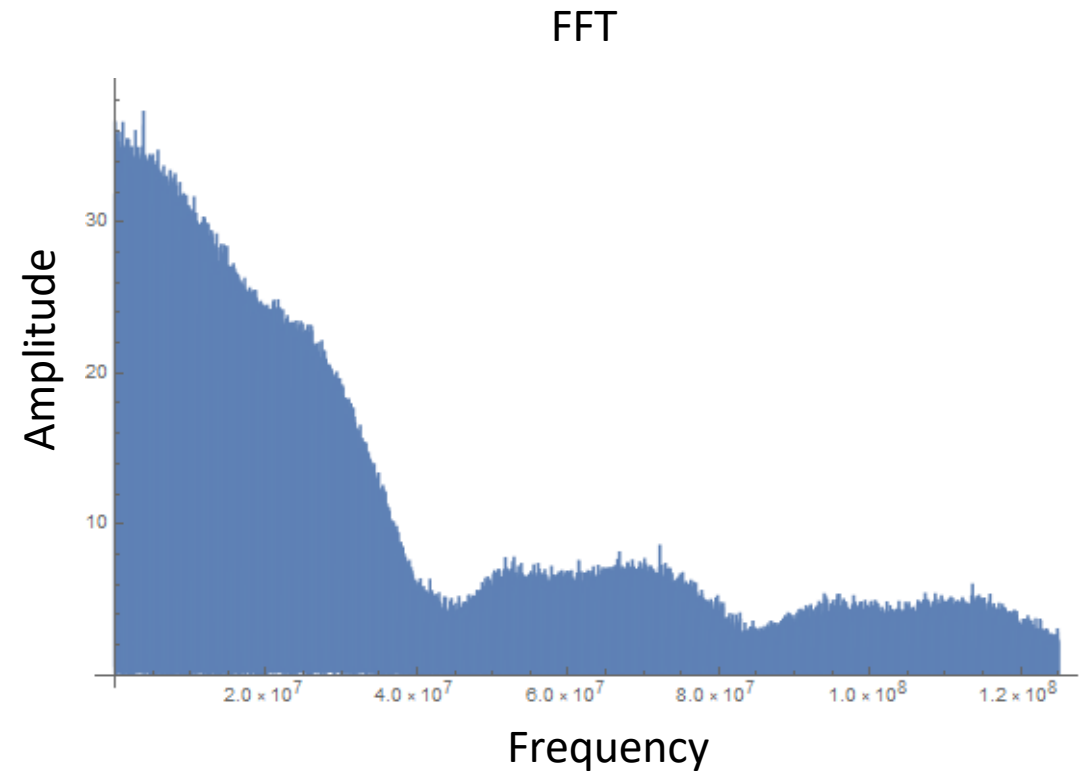
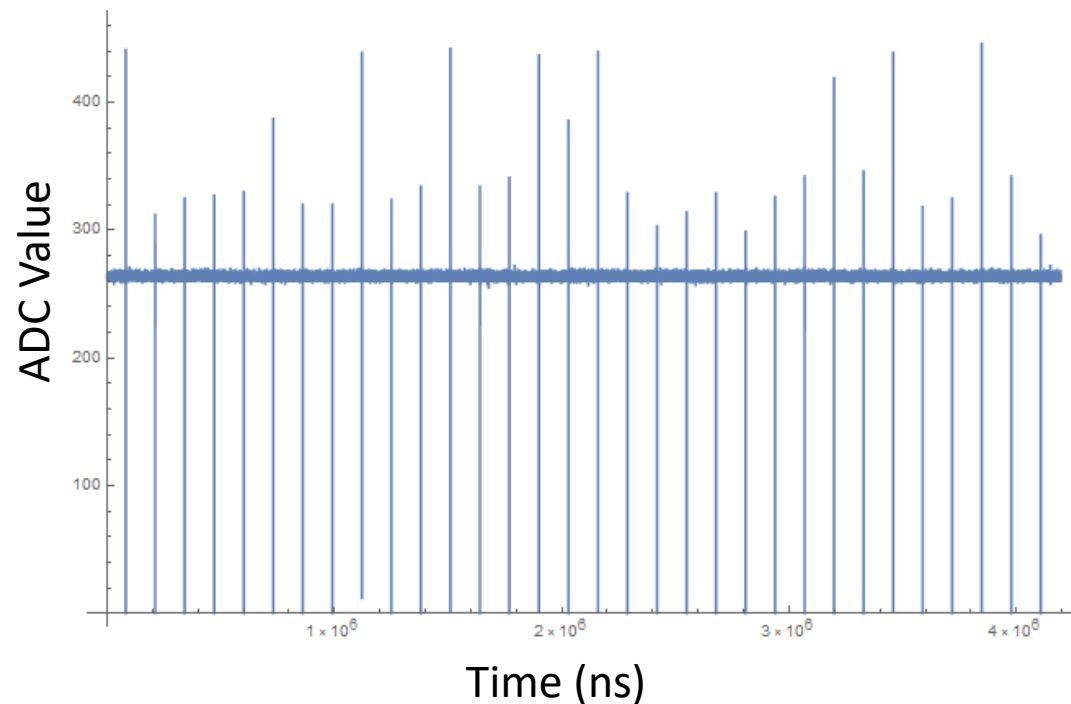
Signals sampled at 250MSPS



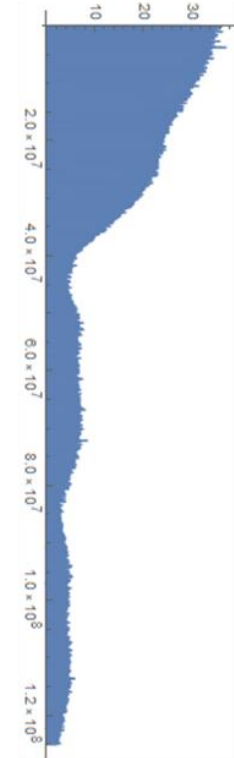
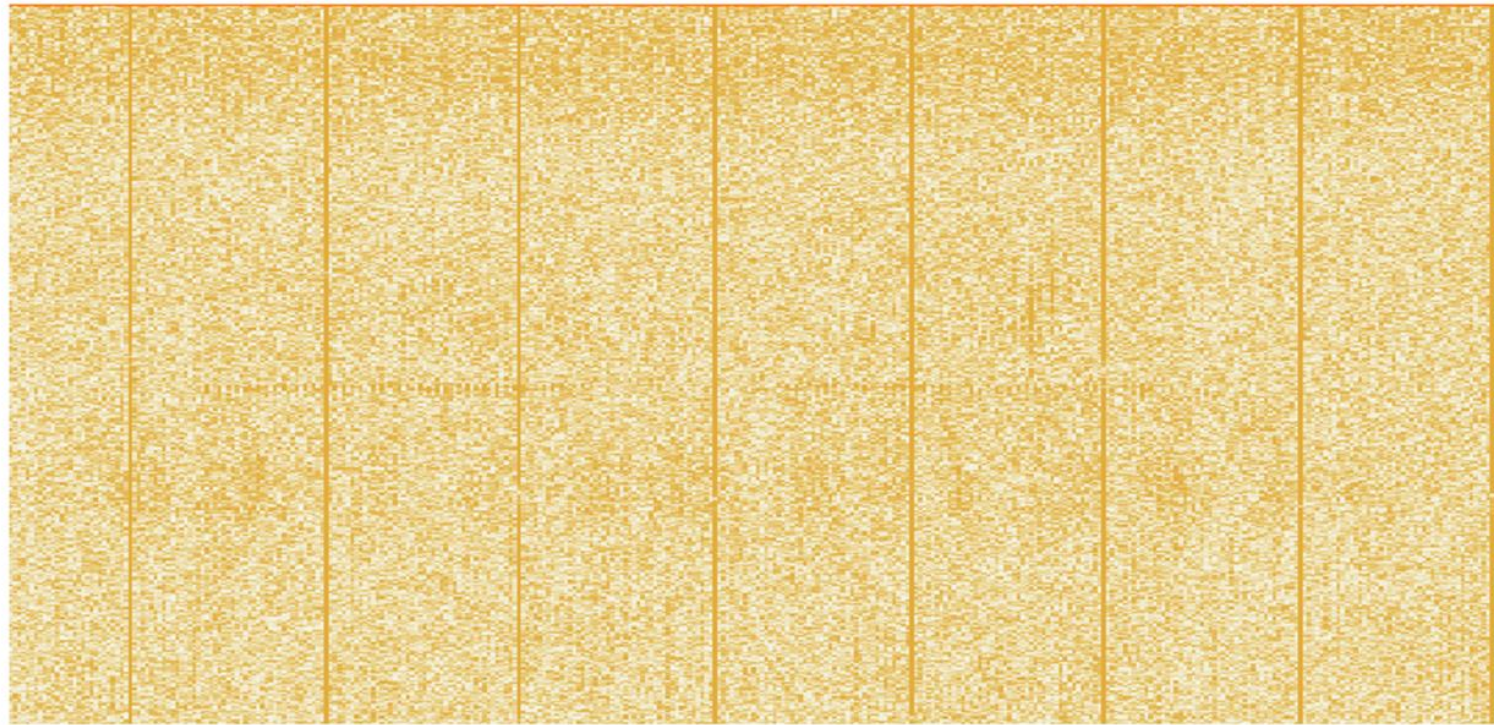
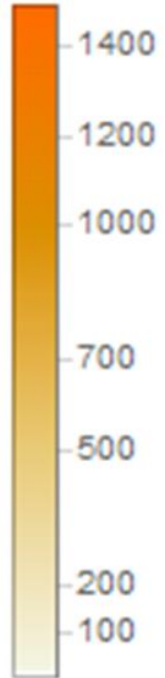
Time (ns)

Spectrum of Signal Before Shaper

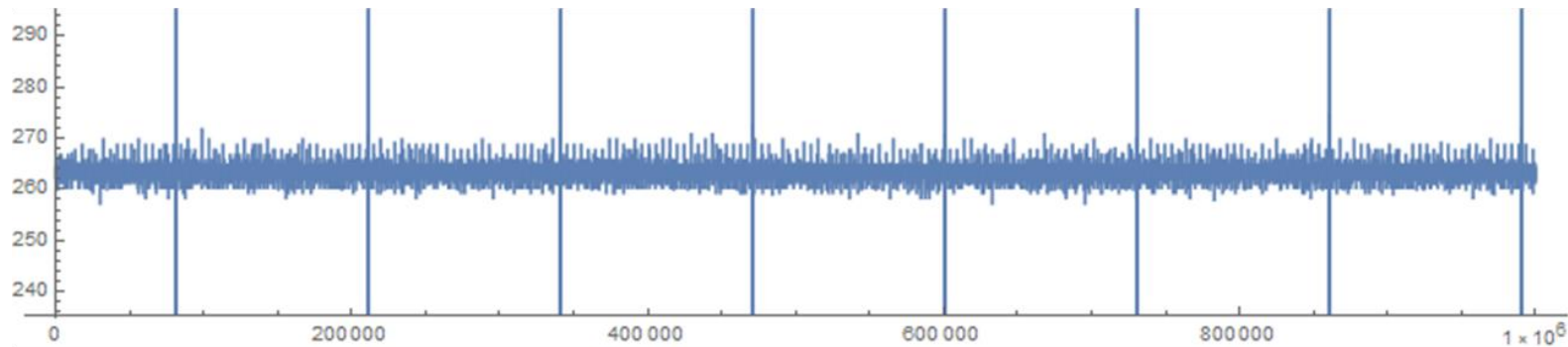
Decimation factor: 2, Effective sampling frequency: 250 Mhz



Time window 2.5 (μs)



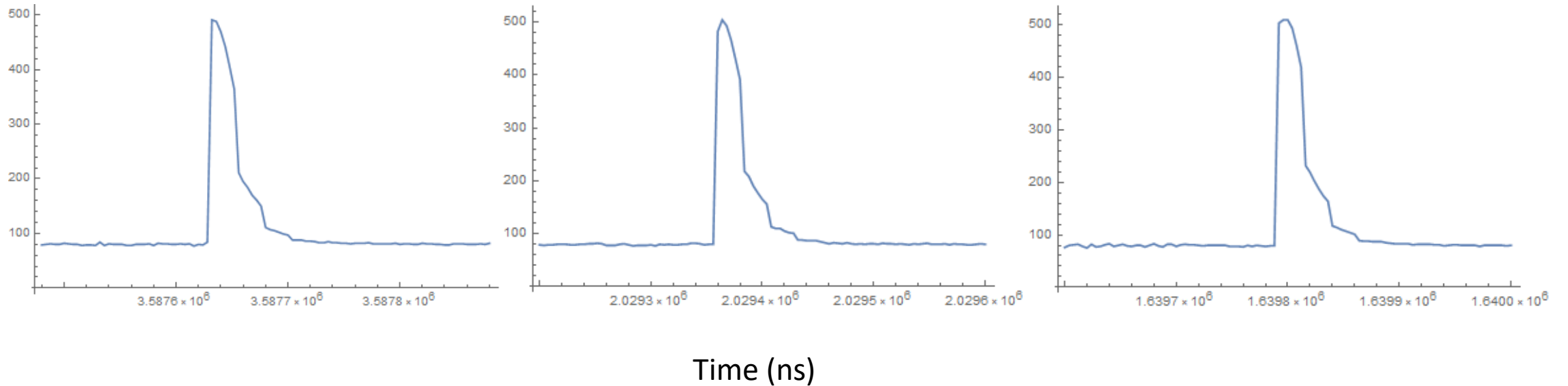
FFT (Hz)



Time (ns)

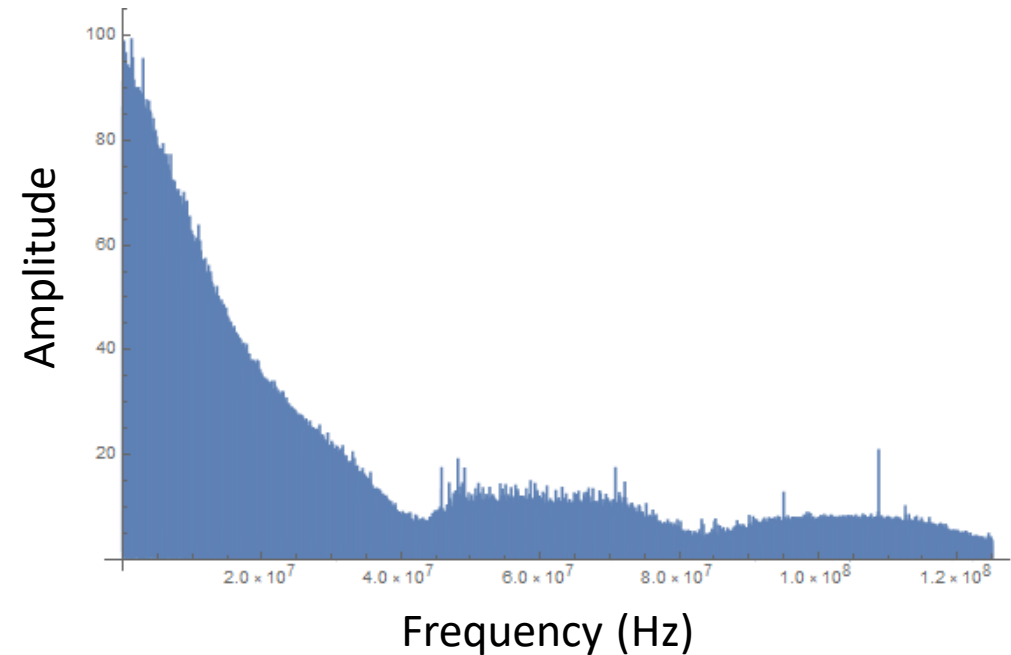
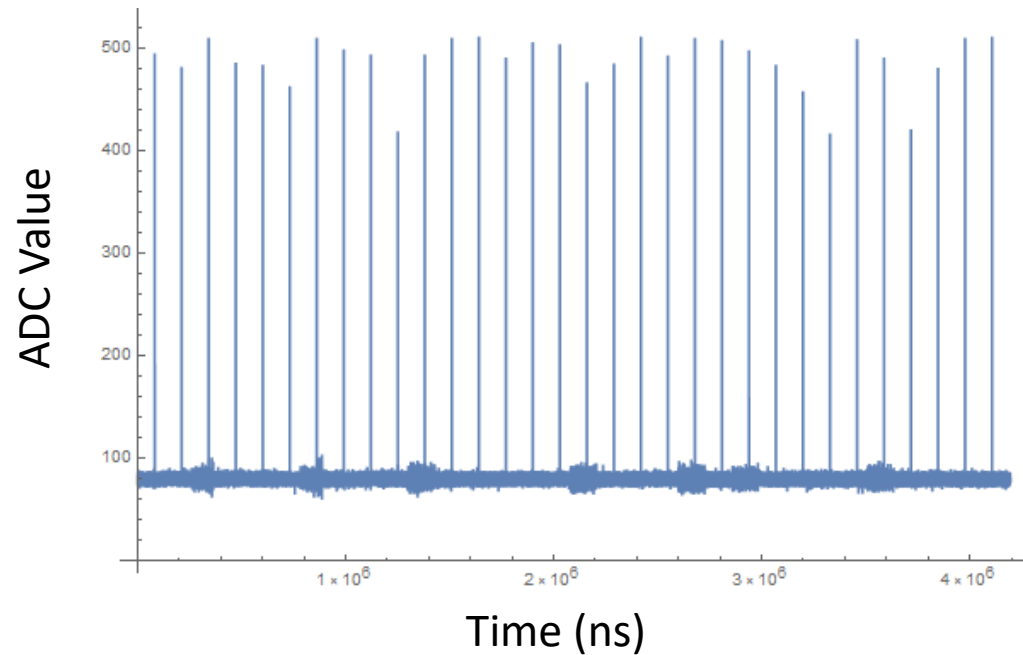
Pulses After Shaper

Signals sampled at 250MSPS

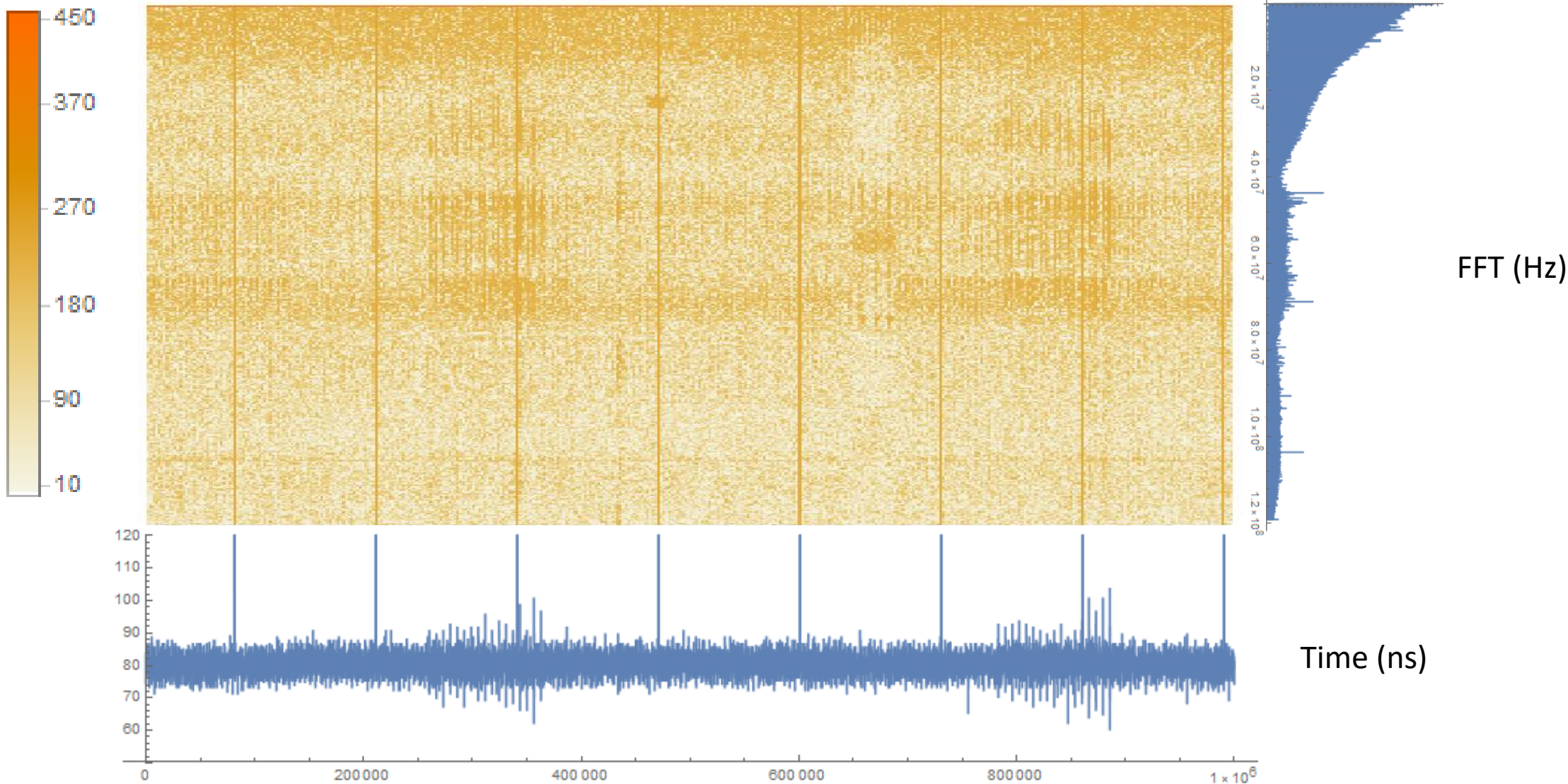


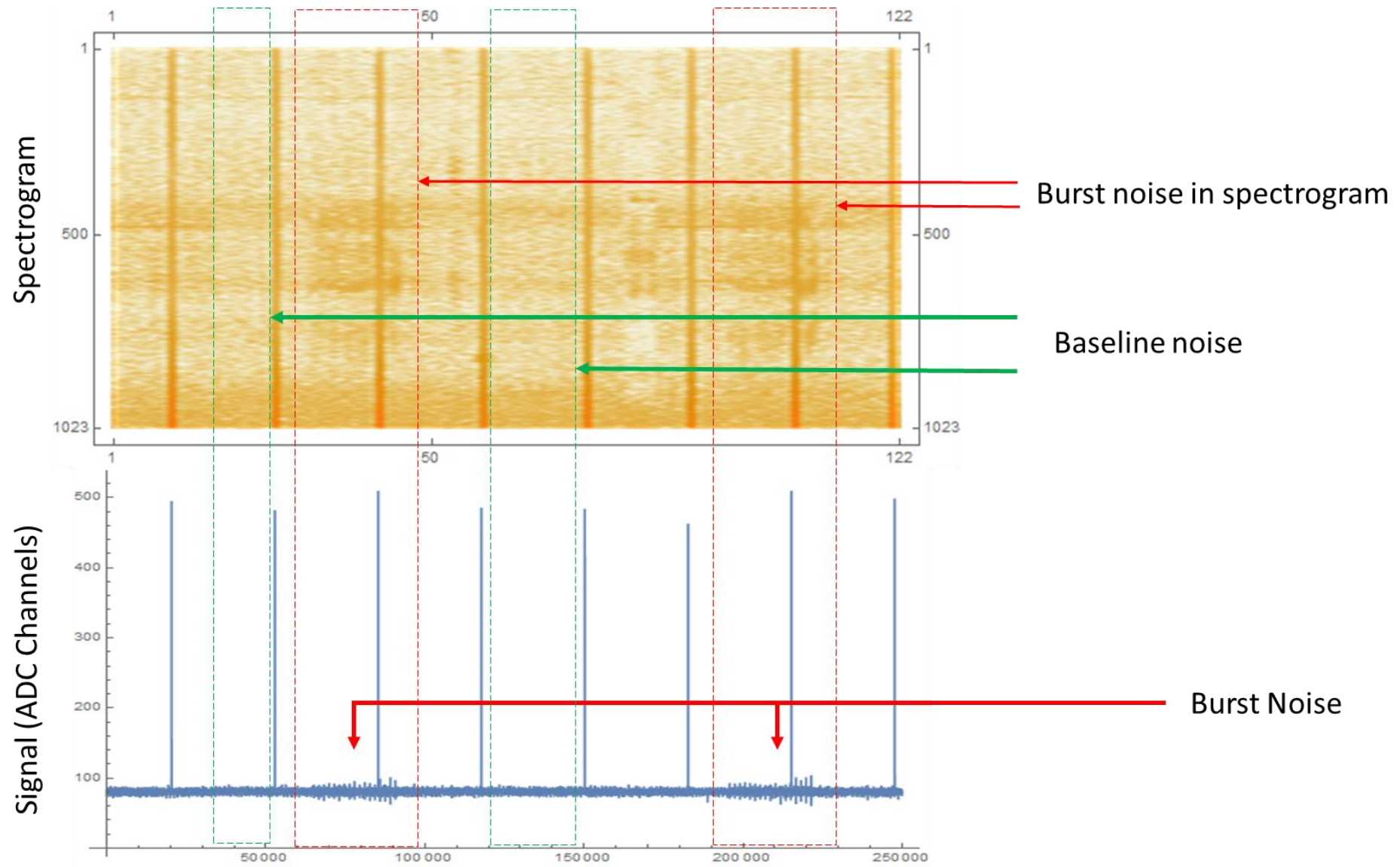
Spectrum of Signals after Shaper

Decimation factor: 2, Effective sampling frequency: 250 Mhz



Time window 2.5 (μ s)

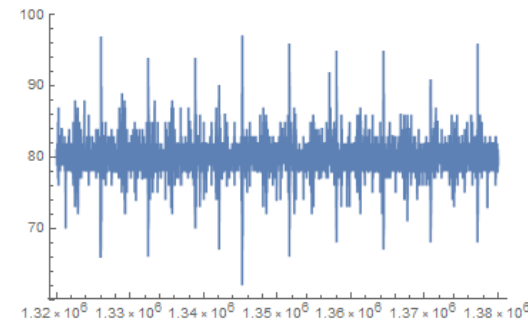
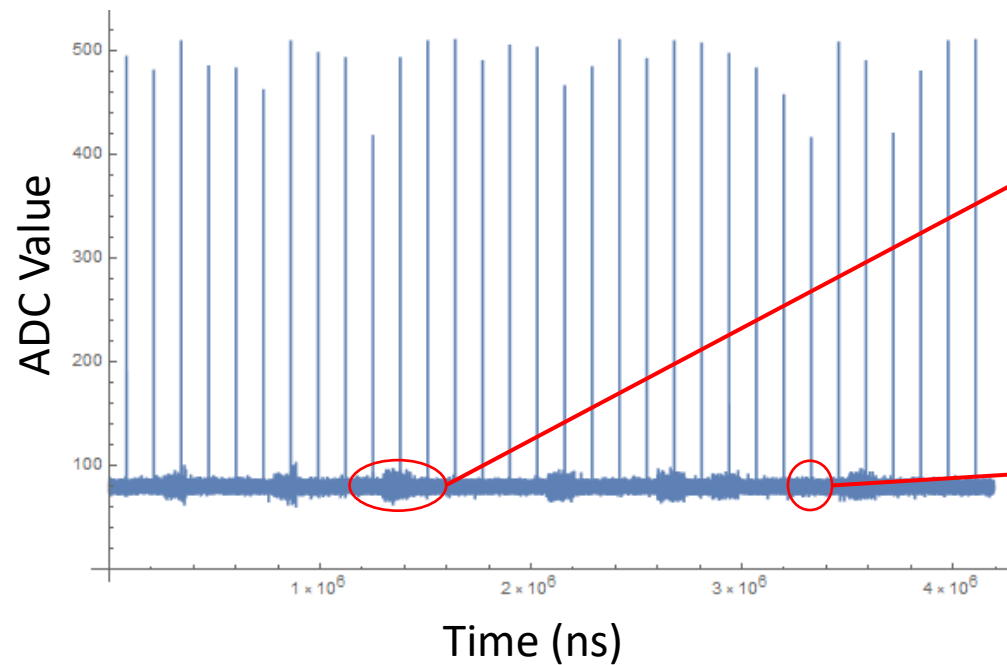




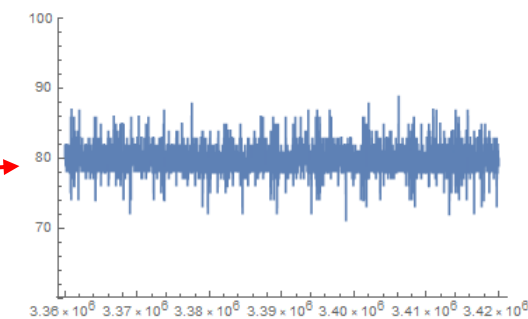
Noise Analysis after Shaper

Decimation factor: 2, Effective sampling frequency: 250 MSPS

Two noise regimes identified



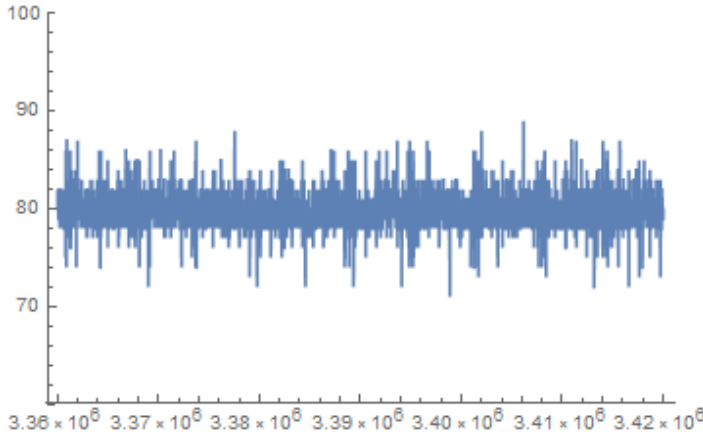
Burst noise 15KS
RMS = 80.0459
STD = 1.81031
Peak to peak = 35



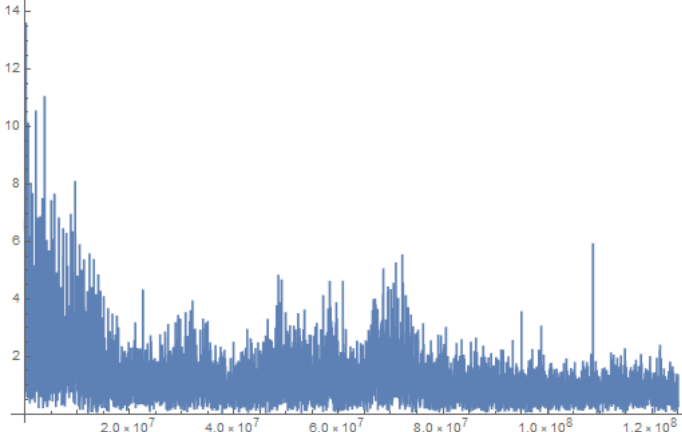
Noise 15KS
RMS = 79.9201
STD = 1.45537
Peak to peak = 18

Burst noise and Baseline noise Comparison

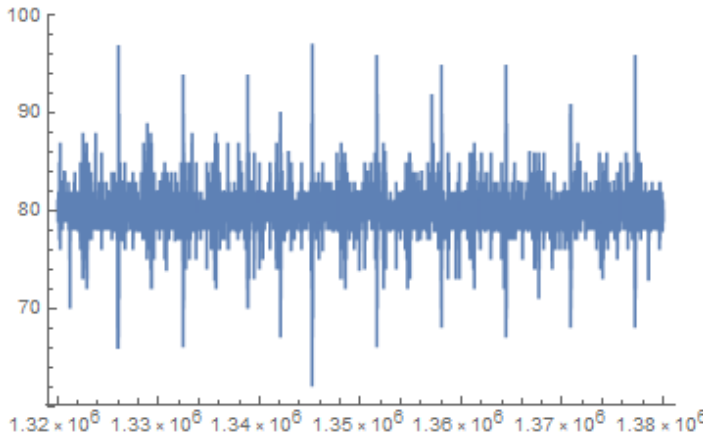
Baseline noise



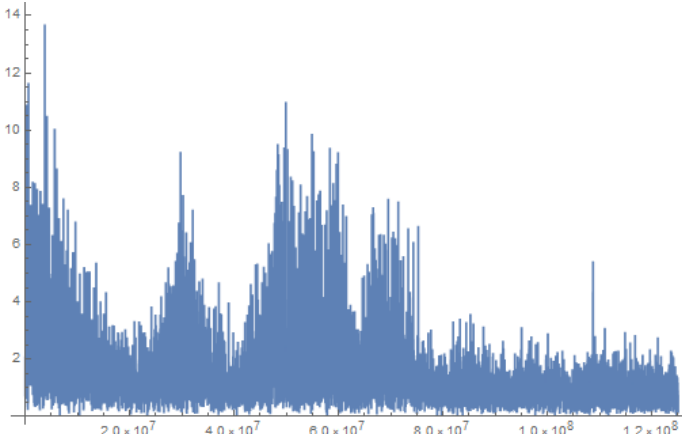
Baseline noise FFT



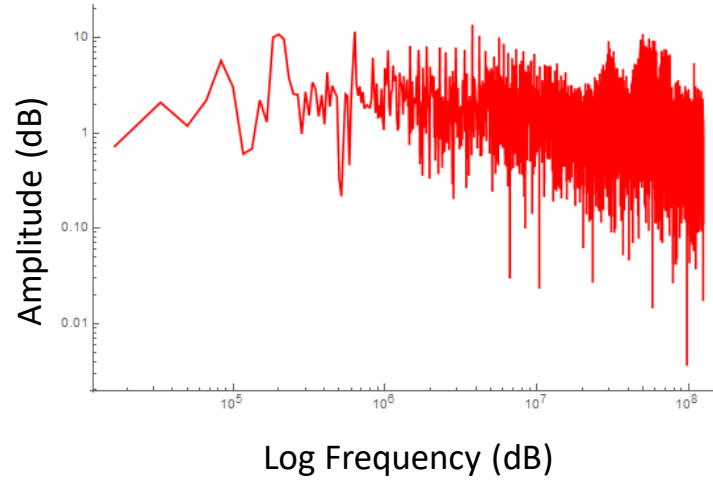
Burst noise



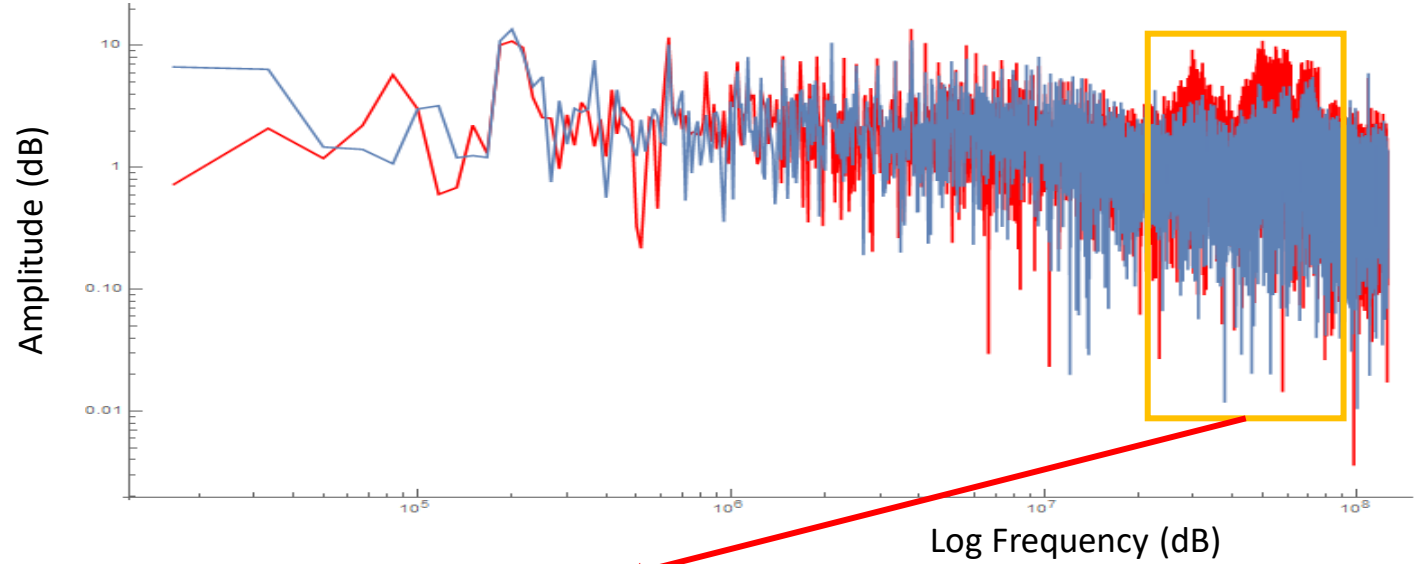
Burst noise FFT



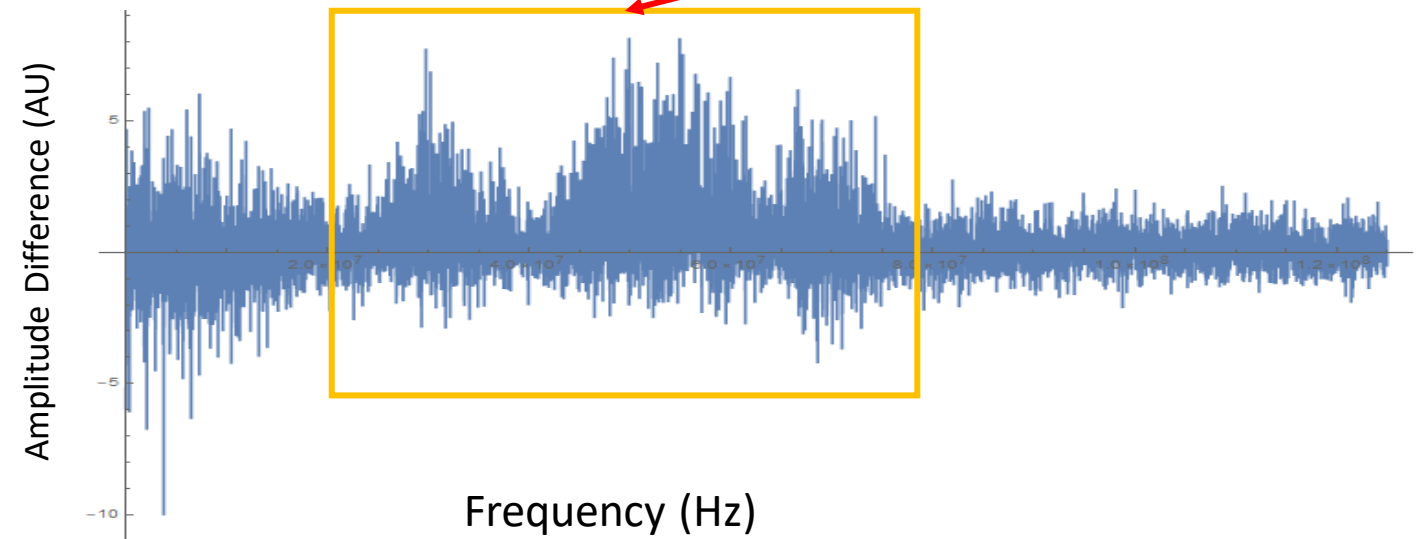
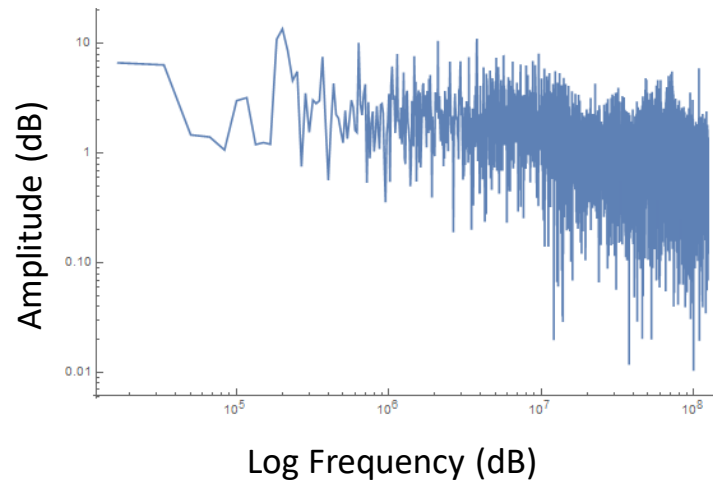
FFT Burst noise

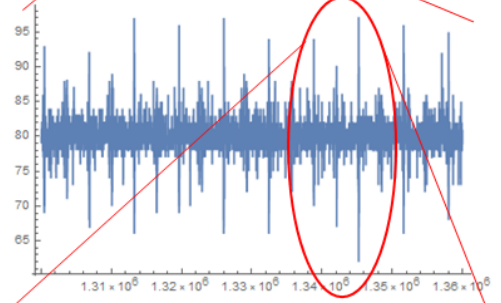
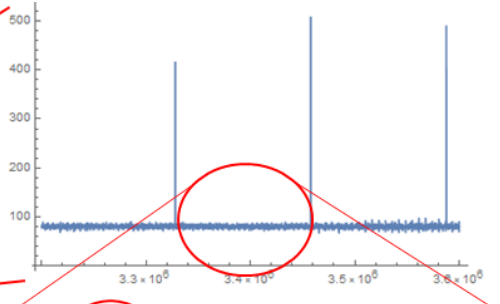
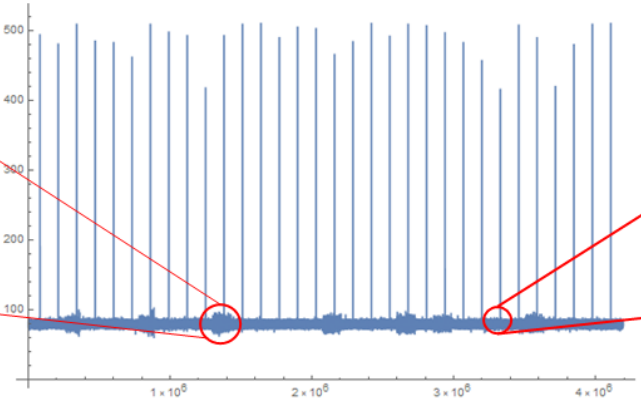
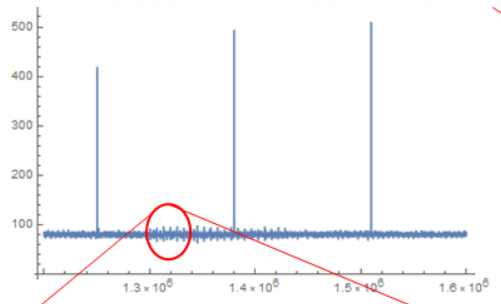


FFT Burst Noise and Baseline Compared

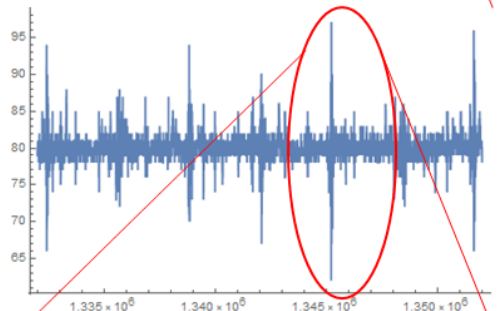
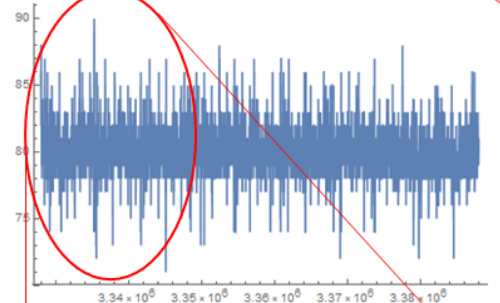


FFT Baseline noise



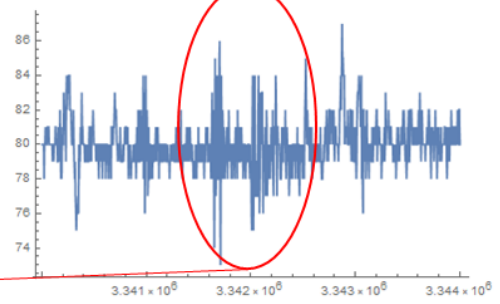
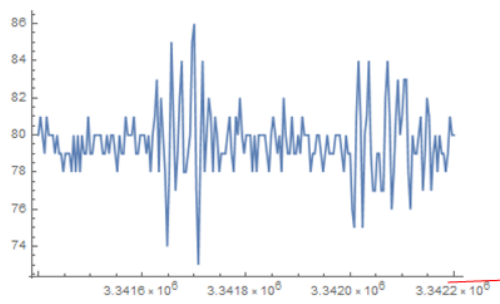
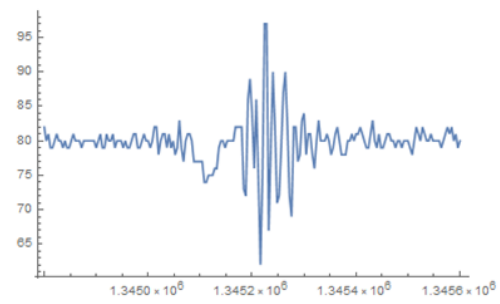
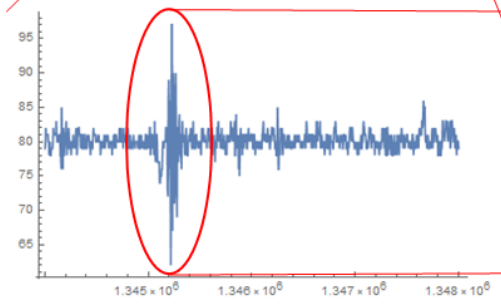
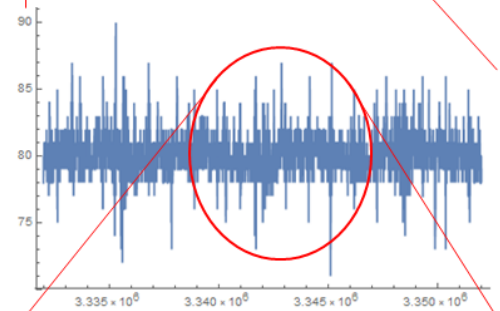


Qualitative Analysis of Both Noise Regimes

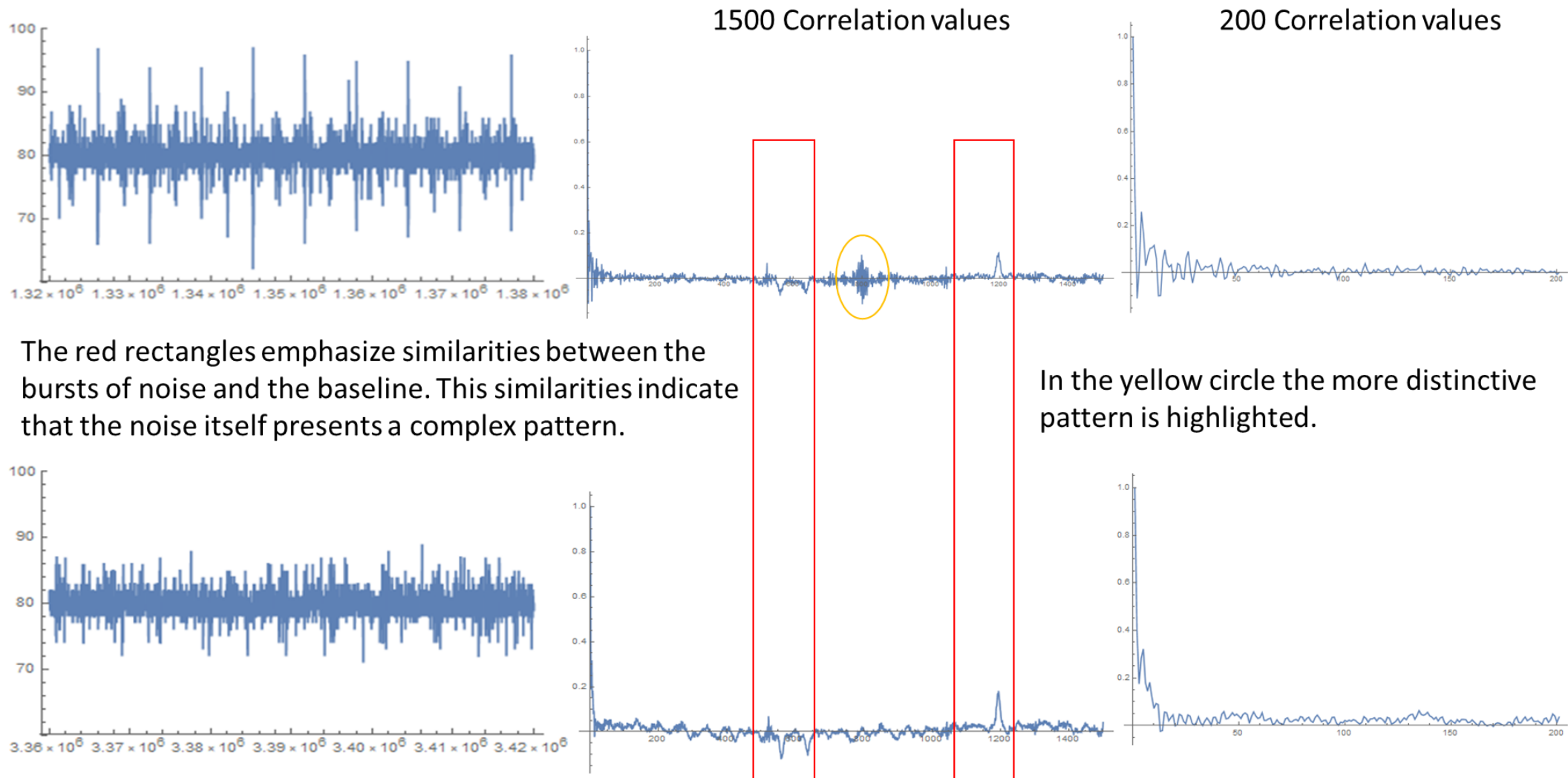


Burst noise

Noise



Comparison of Autocorrelation of Both Noise Regimes



The red rectangles emphasize similarities between the bursts of noise and the baseline. This similarities indicate that the noise itself presents a complex pattern.

In the yellow circle the more distinctive pattern is highlighted.

Conclusions

- Satisfactory ideal pulse model identified
- Observed complex noise structures. It may need further analysis.
- Data analysis procedure has been defined and seems ready for channel by channel massive data analysis including:
 - Model parameters extraction
 - Noise autocorrelation function

Next Steps:

Design of a reconfigurable digital pulse processor for amplitude measurement ECAL2

FIR optimization

Pile-up rejection strategy implementation